

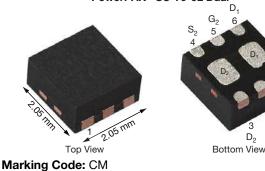
www.vishay.com

Vishay Siliconix

Dual N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω) MAX.	I _D (A)	Q _g (TYP.)		
	0.025 at V _{GS} = 10 V	4.5 ^a			
30	0.029 at V _{GS} = 6 V	4.5 ^a	3 nC		
	0.033 at V _{GS} = 4.5 V	4.5 ^a			

PowerPAK® SC-70-6L Dual



Ordering Information:

SiA928DJ-T1-GE3 (lead (Pb)-free and halogen free)

FEATURES

- TrenchFET® Gen IV power MOSFET
- Thermally enhanced PowerPAK® SC-70 package
 - Small footprint area
 - Low on-resistance
- 100 % Ra tested

• Material categorization: for definitions of compliance please www.vishav.com/doc?99912

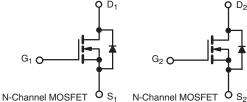


RoHS COMPLIANT HALOGEN

FREE

APPLICATIONS

- Portable devices such as smart phones, tablet PCs and mobile computing
 - Load switch
 - DC/DC converter
 - Power management



PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	30		
Gate-Source Voltage		V _{GS}	+20 / -16	V	
	T _C = 25 °C		4.5 ^a		
Continuous Drain Current /T 150 °C\	T _C = 70 °C		4.5 ^a		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	4.5 ^{a, b, c}		
	T _A = 70 °C		4.5 ^{a, b, c}	А	
Pulsed Drain Current (t = 100 μs)		I _{DM}	30		
0 11 0 0 0 1	T _C = 25 °C		4.5 ^a		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	1.6 ^{b, c}		
	T _C = 25 °C		7.8		
Maximum Power Dissipation	T _C = 70 °C		5	10/	
	T _A = 25 °C	P _D	1.9 ^{b, c}	W	
	T _A = 70 °C		1.2 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150	°C	
Soldering Recommendations (Peak temperature) d,e			260		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum Junction-to-Ambient b, f	t ≤ 5 s	R_{thJA}	52	65	°C/W	
Maximum Junction-to-Case (Drain)	Steady state	R _{thJC}	12.5	16		

- a. Package limited, T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- d. See solder profile (<u>www.vishay.com/doc?73257</u>). The PowerPAK SC-70 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state condition is 110 °C/W.



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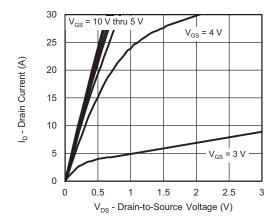
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static			ı	l	l		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30	-	-	V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = 250 μA	-	14.7	-	mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$		-	-4.6	-		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.2	-	2.2	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20 / -16 \text{ V}$	-	-	± 100	nA	
Zone Cote Voltage Dusin Comment	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V	-	-	1	,,,	
Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$		-	10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	5	-	-	Α	
		V _{GS} = 10 V, I _D = 5 A	-	0.020	0.025	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 6 V, I _D = 4 A	-	0.023	0.029		
		$V_{GS} = 4.5 \text{ V}, I_D = 4 \text{ A}$	-	0.026	0.033		
Forward Transconductance ^a	g _{fs}	V _{DS} = 15 V, I _D = 5 A	-	25	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}		-	490	-	pF	
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	150	-		
Reverse Transfer Capacitance	C _{rss}		-	10	-		
C _{rss} /C _{iss} Ratio			-	0.021	0.042	-	
Fotal Gate Charge	Qg	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 5 A	-	6.6	10	nC	
Total Gate Charge		V _{DS} = 15 V, V _{GS} = 4.5 V, I _D = 5 A	-	3	4.5		
Gate-Source Charge	Q_{gs}		-	1.4	-		
Gate-Drain Charge	Q_{gd}		-	0.5	-		
Output Charge	Q _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}$	-	4.2	-		
Gate Resistance	R_g	f = 1 MHz	0.9	4.6	6.9	Ω	
Turn-On Delay Time	t _{d(on)}		-	13	25	- ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 3 Ω	-	45	90		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	-	13	25		
Fall Time	t _f		-	25	50		
Turn-On Delay Time	t _{d(on)}		-	5	10		
Rise Time	t _r	V_{DD} = 15 V, R_L = 3 Ω	-	27	55		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 5$ A, $V_{GEN}=10$ V, $R_g=1$ Ω	-	10	20		
Fall Time	t _f		_	8	15		
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	T _C = 25 °C		-	4.5	А	
Pulse Diode Forward Current	I _{SM}		-	-	30	A	
Body Diode Voltage	V_{SD}	I _S = 5 A, V _{GS} = 0 V	-	0.85	1.2	٧	
Body Diode Reverse Recovery Time	t _{rr}		-	20	40	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	$I_F = 5 A$, $dI/dt = 100 A/\mu s$,	-	7	15	nC	
Reverse Recovery Fall Time	ta	T _J = 25 °C	-	9.5	-	- ns	
Reverse Recovery Rise Time	t _b		_	10.5	1		

Notes

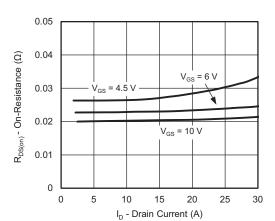
- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

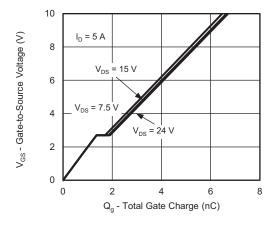




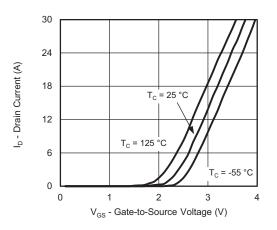
Output Characteristics



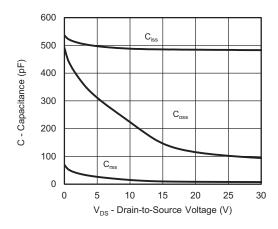
On-Resistance vs. Drain Current and Gate Voltage



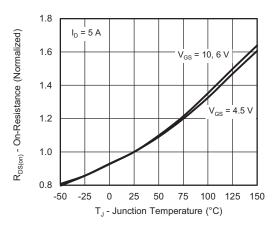
Gate Charge



Transfer Characteristics

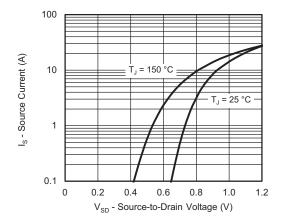


Capacitance

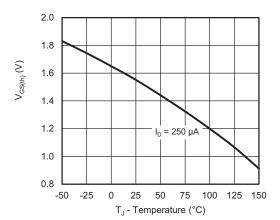


On-Resistance vs. Junction Temperature

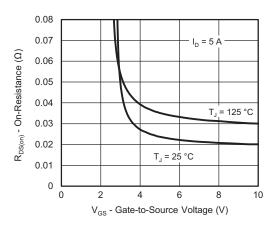




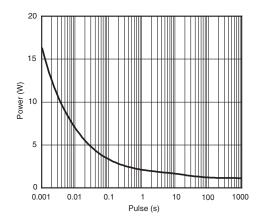
Source-Drain Diode Forward Voltage



Threshold Voltage

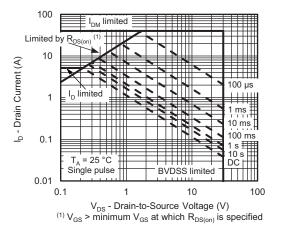


On-Resistance vs. Gate-to-Source Voltage

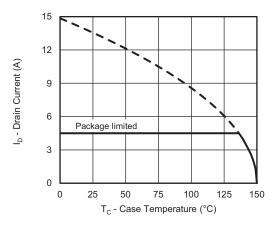


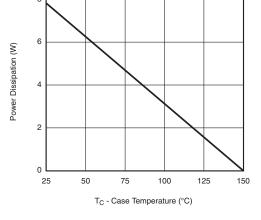
Single Pulse Power (Junction-to-Ambient)





Safe Operating Area, Junction-to-Ambient





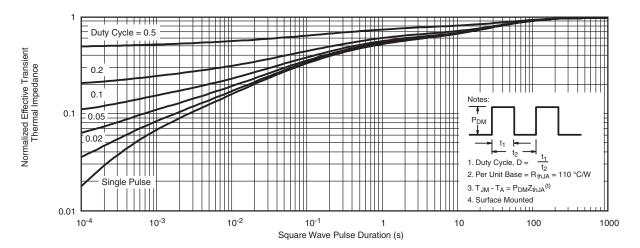
Current Derating ^a

Power Derating

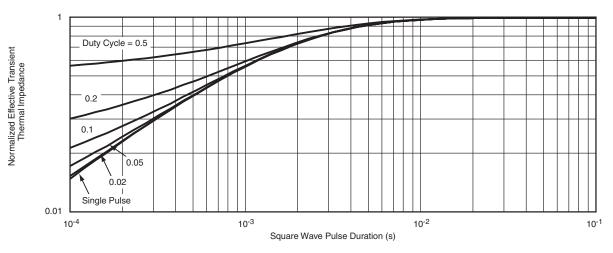
Note

a. The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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